


<b>Search Notes</b> 	<b>Application/Control No.</b> 10586607	<b>Applicant(s)/Patent Under Reexamination</b> KOHNO ET AL.
	<b>Examiner</b> THOMAS DIAZ	<b>Art Unit</b> 3656

SEARCHED			
Class	Subclass	Date	Examiner
74	606R, 607	01/08/2009	/TD/
475	246, 230	01/08/2009	/TD/
Updated	above.	07/29/2009	/TD/
Updated	above.	01/12/2009	/TD/

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor Search done in PALM/eDAN.	01/08/2009	/TD/
Search of US and Foreign patents done in EAST.	01/08/2009	/TD/
Consulted with Vinh Luong, primary in 74.	01/08/2009	/TD/
Updated Text search done in EAST.	07/29/2009	/TD/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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